# **Protected Power MOSFET**

2.6 A, 52 V, N–Channel, Logic Level, Clamped MOSFET w/ ESD Protection in a SOT–223 Package

#### Benefits

- High Energy Capability for Inductive Loads
- Low Switching Noise Generation

## Features

- Diode Clamp Between Gate and Source
- ESD Protection HBM 5000 V
- Active Over–Voltage Gate to Drain Clamp
- Scalable to Lower or Higher R<sub>DS(on)</sub>
- Internal Series Gate Resistance
- Pb–Free Packages are Available

## Applications

• Automotive and Industrial Markets: Solenoid Drivers, Lamp Drivers, Small Motor Drivers

## **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage Internally Clamped	V <sub>DSS</sub>	52–59	V
Gate-to-Source Voltage - Continuous	V <sub>GS</sub>	±15	V
Drain Current – Continuous @ $T_A = 25^{\circ}C$ – Single Pulse ( $t_p = 10 \ \mu s$ ) (Note 1)	I <sub>D</sub> I <sub>DM</sub>	2.6 10	A
Total Power Dissipation @ $T_A = 25^{\circ}C$ (Note 1)	PD	1.69	W
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to 150	°C
Single Pulse Drain-to-Source Avalanche Energy (V <sub>DD</sub> = 50 V, I <sub>D(pk)</sub> = 1.17 A, V <sub>GS</sub> = 10 V, L = 160 mH, R <sub>G</sub> = 25 $\Omega$ )	E <sub>AS</sub>	110	mJ
Thermal Resistance, Junction–to–Ambient (Note 1) Junction–to–Ambient (Note 2)	$R_{ heta JA}$ $R_{ heta JA}$	74 169	°C/W
Maximum Lead Temperature for Soldering Purposes, 1/8" from Case for 10 Seconds	ΤL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

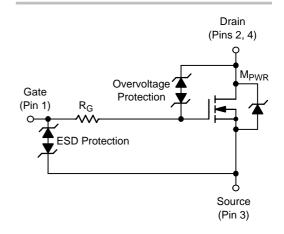
- 1. When surface mounted to a FR4 board using 1" pad size, (Cu area 1.127 in<sup>2</sup>).
- When surface mounted to a FR4 board using minimum recommended pad size, (Cu area 0.412 in<sup>2</sup>).



# **ON Semiconductor®**

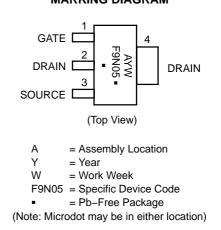
#### http://onsemi.com

V <sub>DSS</sub> (Clamped)	R <sub>DS(ON)</sub> TYP	I <sub>D</sub> MAX
52 V	107 m $\Omega$	2.6 A





MARKING DIAGRAM



## ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

Charac	Symbol	Min	Тур	Max	Unit	
OFF CHARACTERISTICS		·				
Drain-to-Source Breakdown Voltage (Note 3) ( $V_{GS} = 0 V$ , $I_D = 1.0 mA$ , $T_J = 25^{\circ}C$ ) ( $V_{GS} = 0 V$ , $I_D = 1.0 mA$ , $T_J = -40^{\circ}C$ to 125°C) Temperature Coefficient (Negative)		V <sub>(BR)DSS</sub>	52 50.8	55 54 –9.3	59 59.5	V V mV/°C
Zero Gate Voltage Drain Current $(V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V})$ $(V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 125^{\circ}\text{C})$		I <sub>DSS</sub>			10 25	μΑ
Gate-Body Leakage Current $(V_{GS} = \pm 8 \text{ V}, V_{DS} = 0 \text{ V})$ $(V_{GS} = \pm 14 \text{ V}, V_{DS} = 0 \text{ V})$		I <sub>GSS</sub>		±22	±10	μΑ
ON CHARACTERISTICS (Note 3)						
Gate Threshold Voltage (Note 3) $(V_{DS} = V_{GS}, I_D = 100 \ \mu A)$ Threshold Temperature Coefficient (Negative)		V <sub>GS(th)</sub>	1.3	1.75 -4.1	2.5	V mV/°C
Static Drain-to-Source On-Resistance (Note 3) ( $V_{GS} = 3.5 \text{ V}, I_D = 0.6 \text{ A}$ ) ( $V_{GS} = 4.0 \text{ V}, I_D = 1.5 \text{ A}$ ) ( $V_{GS} = 10 \text{ V}, I_D = 2.6 \text{ A}$ )		R <sub>DS(on)</sub>		190 165 107	380 200 125	mΩ
Forward Transconductance (Note 3) ( $V_{I}$	<sub>DS</sub> = 15 V, I <sub>D</sub> = 2.6 A)	9 <sub>FS</sub>		3.8		Mhos
DYNAMIC CHARACTERISTICS						
Input Capacitance		C <sub>iss</sub>		155	250	pF
Output Capacitance	$V_{DS} = 35 \text{ V}, V_{GS} = 0 \text{ V},$ f = 10 kHz	C <sub>oss</sub>		60	100	
Transfer Capacitance		C <sub>rss</sub>		25	40	
Input Capacitance		C <sub>iss</sub>		170		pF
Output Capacitance	V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, f = 10 kHz	C <sub>oss</sub>		70		
Transfer Capacitance		C <sub>rss</sub>		30		

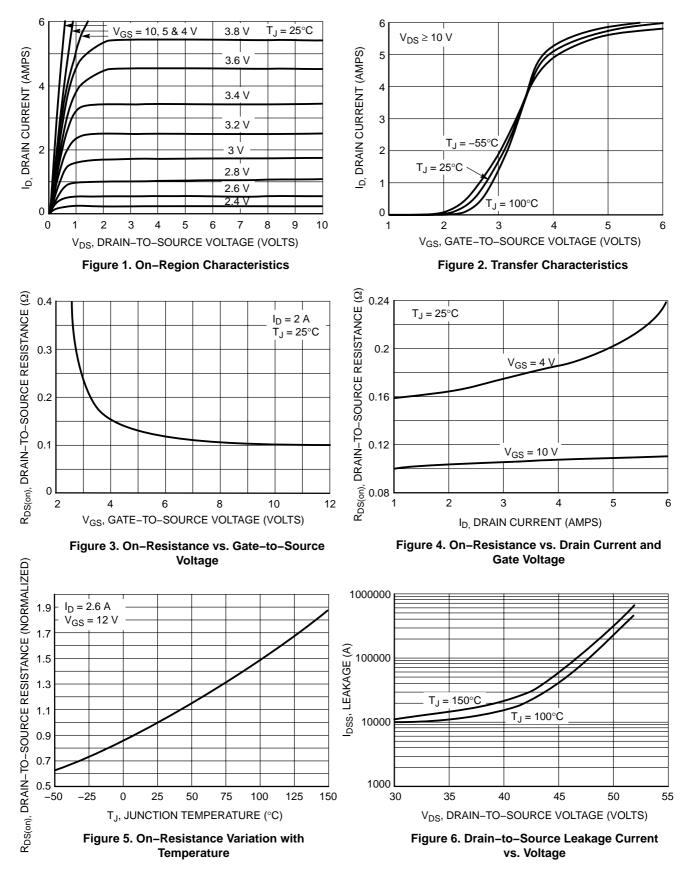
Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
Switching characteristics are independent of operating junction temperatures.

Characteristic			Min	Тур	Max	Unit
SWITCHING CHARACTERISTIC	<b>S</b> (Note 4)					
Turn–On Delay Time		t <sub>d(on)</sub>		275	465	ns
Rise Time	V <sub>GS</sub> = 4.5 V, V <sub>DD</sub> = 40 V,	t <sub>r</sub>		1418	2400	
Turn–Off Delay Time	$I_D = 2.6 \text{ A}, \text{ R}_D = 15.4 \Omega$	t <sub>d(off)</sub>		780	1320	
Fall Time		t <sub>f</sub>		1120	1900	
Turn–On Delay Time		t <sub>d(on)</sub>		242		ns
Rise Time	V <sub>GS</sub> = 4.5 V, V <sub>DD</sub> = 40 V,	t <sub>r</sub>		1165		
Turn–Off Delay Time	$I_D = 1.0 \text{ A}, \text{ R}_D = 40 \Omega$	t <sub>d(off)</sub>		906		l
Fall Time		t <sub>f</sub>		1273		
Turn-On Delay Time		t <sub>d(on)</sub>		107		ns
Rise Time	V <sub>GS</sub> = 10 V, V <sub>DD</sub> = 15 V,	t <sub>r</sub>		290		
Turn-Off Delay Time	$I_{\rm D} = 2.6 \text{ A}, \text{ R}_{\rm D} = 5.8 \Omega$	t <sub>d(off)</sub>		1540		
Fall Time		t <sub>f</sub>		1000		
Gate Charge		QT		4.5	7.0	nC
	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 40 V, I <sub>D</sub> = 2.6 A (Note 3)	Q <sub>1</sub>		0.9		1
		Q <sub>2</sub>		2.6		
Gate Charge	arge			3.9		nC
	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V, I <sub>D</sub> = 1.5 A (Note 3)	Q <sub>1</sub>		1.0		-
		Q <sub>2</sub>		1.7		
SOURCE-DRAIN DIODE CHAR	ACTERISTICS					
Forward On–Voltage	$I_{S} = 2.6 \text{ A}, V_{GS} = 0 \text{ V} \text{ (Note 3)}$ $I_{S} = 2.6 \text{ A}, V_{GS} = 0 \text{ V}, T_{J} = 125^{\circ}\text{C}$	V <sub>SD</sub>		0.81 0.66	1.5	V
Reverse Recovery Time	se Recovery Time			730		ns
	$I_{S} = 1.5 \text{ A}, V_{GS} = 0 \text{ V},$ $dI_{s}/dt = 100 \text{ A}/\mu \text{s} \text{ (Note 3)}$	t <sub>a</sub>		200		7
		t <sub>b</sub>		530		
Reverse Recovery Stored Charge	Q <sub>RR</sub>		6.3		μC	

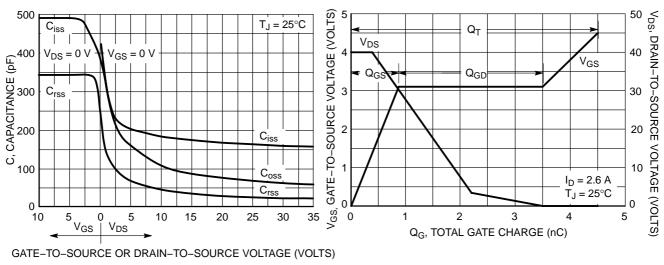
#### ESD CHARACTERISTICS

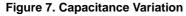
Electro-Static Discharge Capability	Human Body Model (HBM)	ESD	5000		V
	Machine Model (MM)		500		





## **TYPICAL PERFORMANCE CURVES**







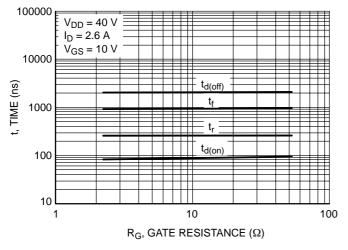


Figure 9. Resistance Switching Time Variation vs. Gate Resistance

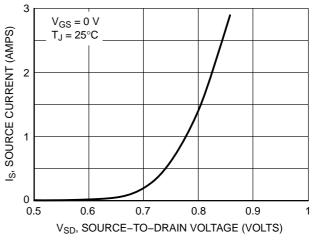


Figure 10. Diode Forward Voltage vs. Current

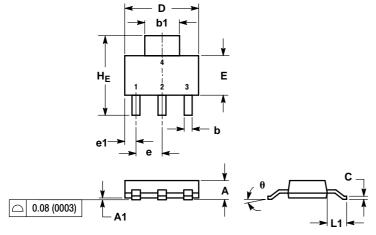
#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NIF9N05CLT1	SOT-223	
NIF9N05CLT1G	SOT-223 (Pb-Free)	1000 / Tape & Reel
NIF9N05CLT3	SOT-223	
NIF9N05CLT3G	SOT-223 (Pb-Free)	4000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### PACKAGE DIMENSIONS

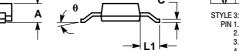
SOT-223 (TO-261) CASE 318E-04 ISSUE L



NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982

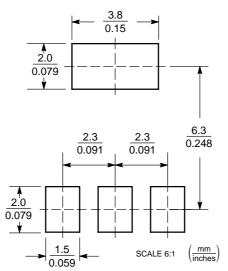
2. CONTROLLING DIMENSION: INCH.

	м	MILLIMETERS			INCHES		
DIM	MIN	NOM	MAX	MIN	MIN NOM		
Α	1.50	1.63	1.75	0.060	0.064	0.068	
A1	0.02	0.06	0.10	0.001	0.002	0.004	
b	0.60	0.75	0.89	0.024	0.030	0.035	
b1	2.90	3.06	3.20	0.115	0.121	0.126	
с	0.24	0.29	0.35	0.009	0.012	0.014	
D	6.30	6.50	6.70	0.249	0.256	0.263	
E	3.30	3.50	3.70	0.130	0.138	0.145	
е	2.20	2.30	2.40	0.087	0.091	0.094	
e1	0.85	0.94	1.05	0.033	0.037	0.041	
L1	1.50	1.75	2.00	0.060	0.069	0.078	
HE	6.70	7.00	7.30	0.264	0.276	0.287	
θ	0°	_	10°	0°	_	10°	



PIN 1. GATE 2. DRAIN SOURCE 3. 4 DRAIN

#### **SOLDERING FOOTPRINT\***



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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